

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10620376	HAYASHI ET AL.
Examiner	Art Unit	
Hodge, Robert	1795	

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
Consulted Jonathan Crepeau Re Previous Grounds of Rejection and New Grounds of Rejection and Motivation	10/24/07	RWH
See attached East Search History	10/24/07	RWH
Updated Previous East Search History - See attached East Search History	5/14/08	RWH

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner